VALERIU BEIU — PUBLICATII

SINTETIC	PUBLICATE	ACCEPTATE
CARTI	2	3
CAPITOLE	8 (7 INVITATE)	5
BREVETE	20	
REVISTE	43 (2 INVITATE)	3 (1 INVITATE)
CONFERINTE	225 (28 INVITATE)	
TOTAL	309 (38 INVITATE, 8 BEST PAPER AWARDS)	
ALTE CONFERINTE	53 (7 INVITATE, 1 BEST PAPER AWARD)	
RAPOARTE TEHNICE	73	

CARTI 2

– V. Beiu and U. Rückert (Eds.): Emerging Brain-Inspired Nano-Architectures
Book in progress (contract signed with World Scientific)

– V. Beiu: VLSI Complexity of Discrete Neural Networks
Book in progress (contract signed with Taylor & Francis)

– V. Beiu, R. Andonie, and R. Dogaru: Fundamental Problems of Neural Networks
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··· V. Beiu: Neural Networks Using Threshold Gates
A Complexity Analysis of Their Area- and Time-Efficient VLSI Implementations
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– V. Beiu and W. Ibrahim: On Enabling Redundant Designs for Nano Computations
In V. Beiu and U. Rückert (Eds.): Emerging Brain-Inspired Nano-Architectures

– V. Beiu, J.M. Quintana, and M.J. Avedillo
Threshold Logic Design and Implementations: From the Early Days into the Nanoera
In V. Beiu and U. Rückert (Eds.): Emerging Brain-Inspired Nano-Architectures

– M.H. Sulieman and V. Beiu
From Single Electron Technology (SET) Full Adders to Optimal Practical SET Adders
In V. Beiu and U. Rückert (Eds.): Emerging Brain-Inspired Nano-Architectures

– V. Beiu and U. Rückert: Roadmap for Nano Architectures
In V. Beiu and U. Rückert (Eds.): Emerging Brain-Inspired Nano-Architectures

– J. Nyathi, and V. Beiu: Advanced Techniques for Reducing Power Consumption
In V. Beiu and U. Rückert (Eds.): Emerging Brain-Inspired Nano-Architectures

Ch_8 V. Beiu, L. Zhang, A. Beg, W. Ibrahim, and M. Tache: Axon-Inspired Communication Systems ***Invited₇***
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··· V. Beiu et al.: Brain-inspired Computing Revisited – Why Energy Consumption Is So Elusive In progress
··· V. Beiu et al.: Revisiting Schmitt Trigger Tolerance to Variations In progress
··· V. Beiu, R.-M. Beiu, and V. Dragoi: The Trustworthy Wings of the Mysterious Butterflies To be submitted

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